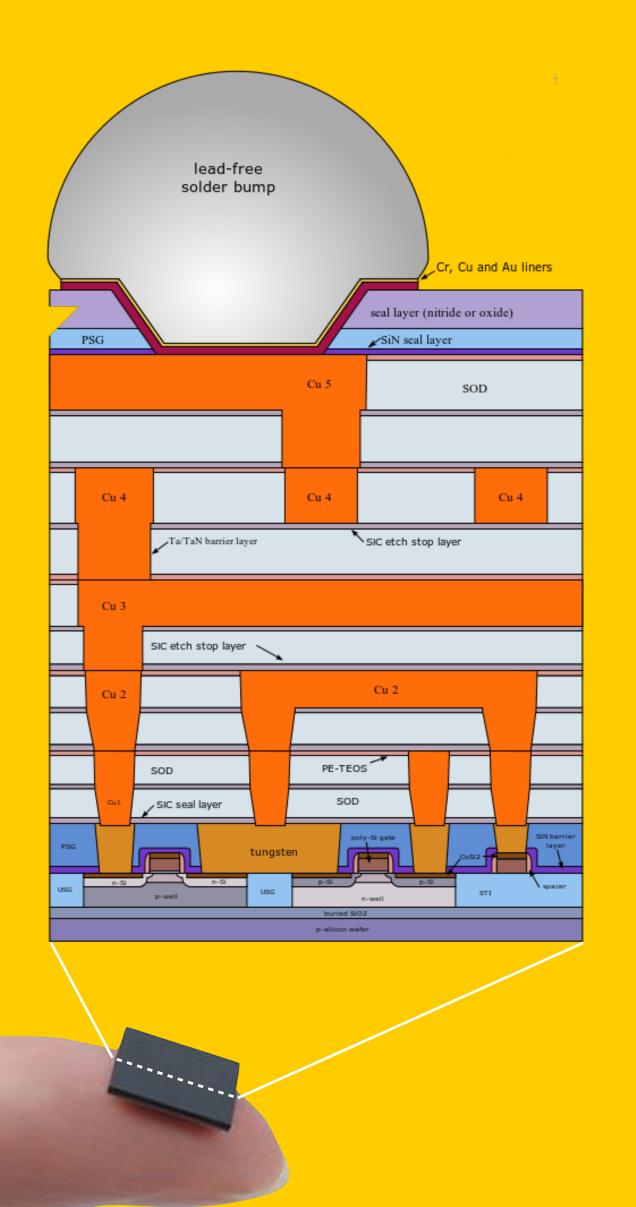


Zero-Iteration Manufacturing



Increasing Complexity in Semiconductors



Hundreds of production steps

Thousands of process parameters

Billions of transistors/chip

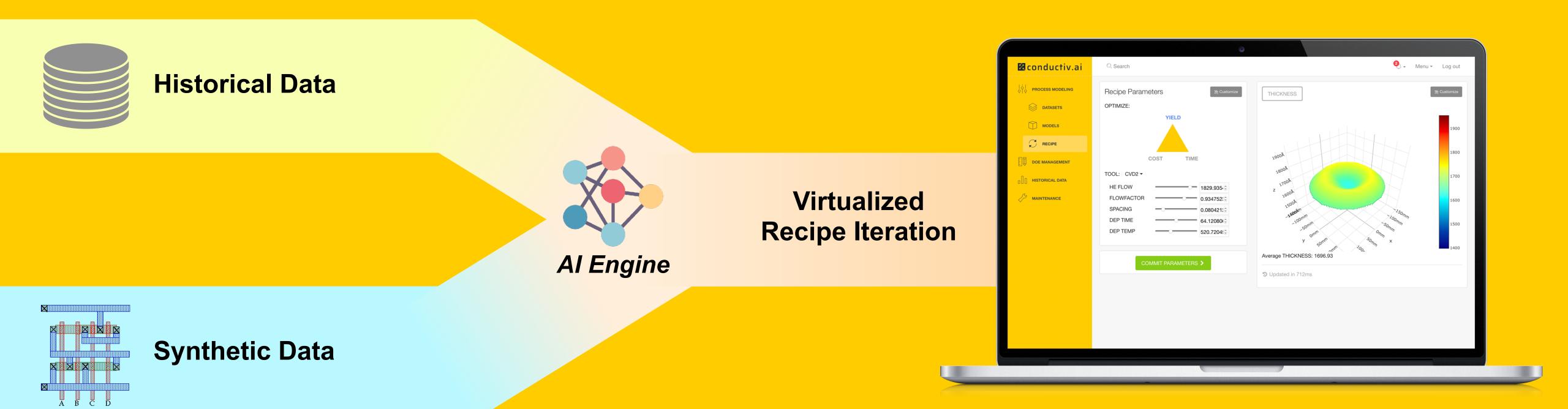


Challenge: Getting to Volume Production ASAP



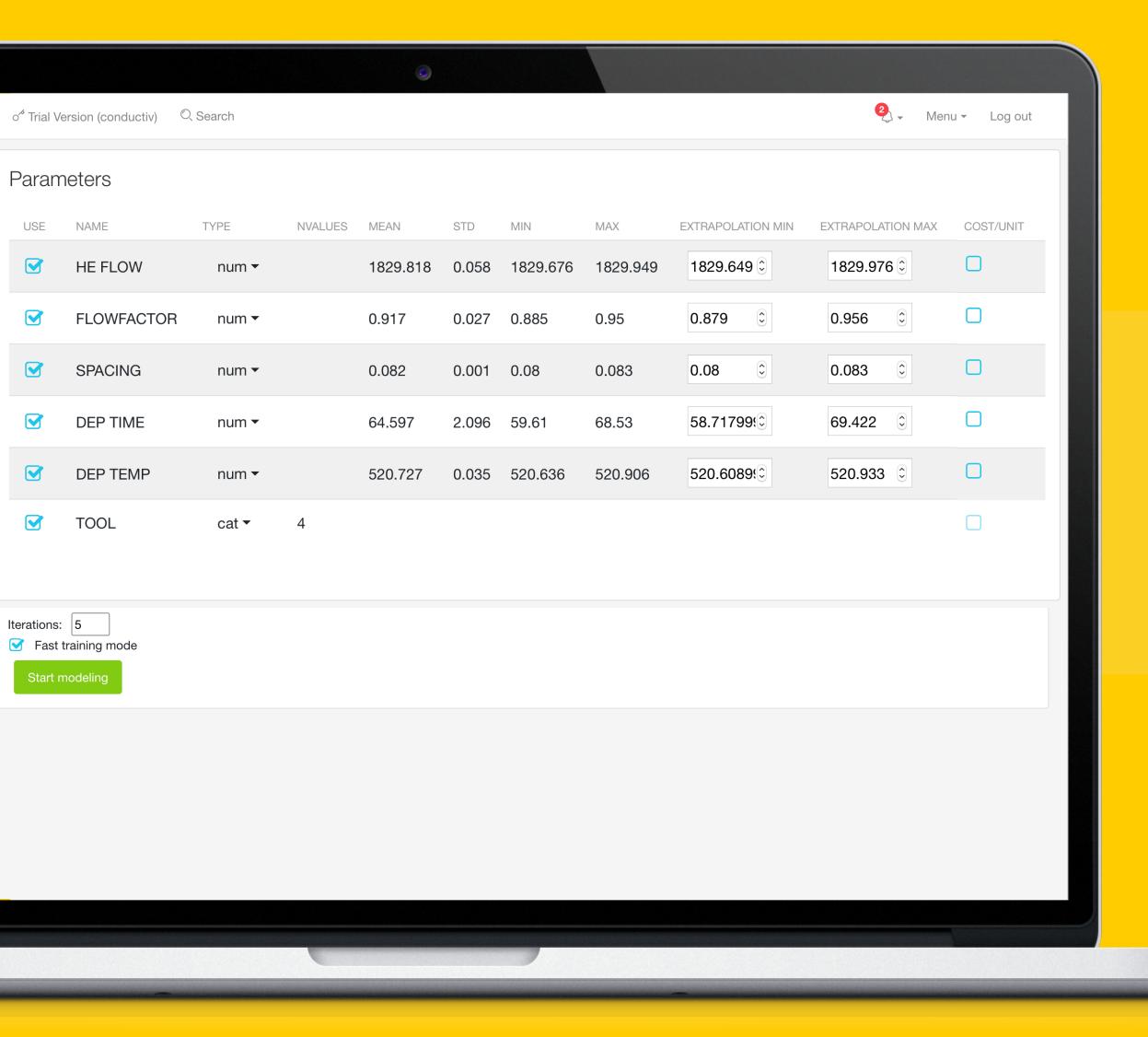


Minimizing Trial & Error With Al





1. Automated Data Pre-Processing



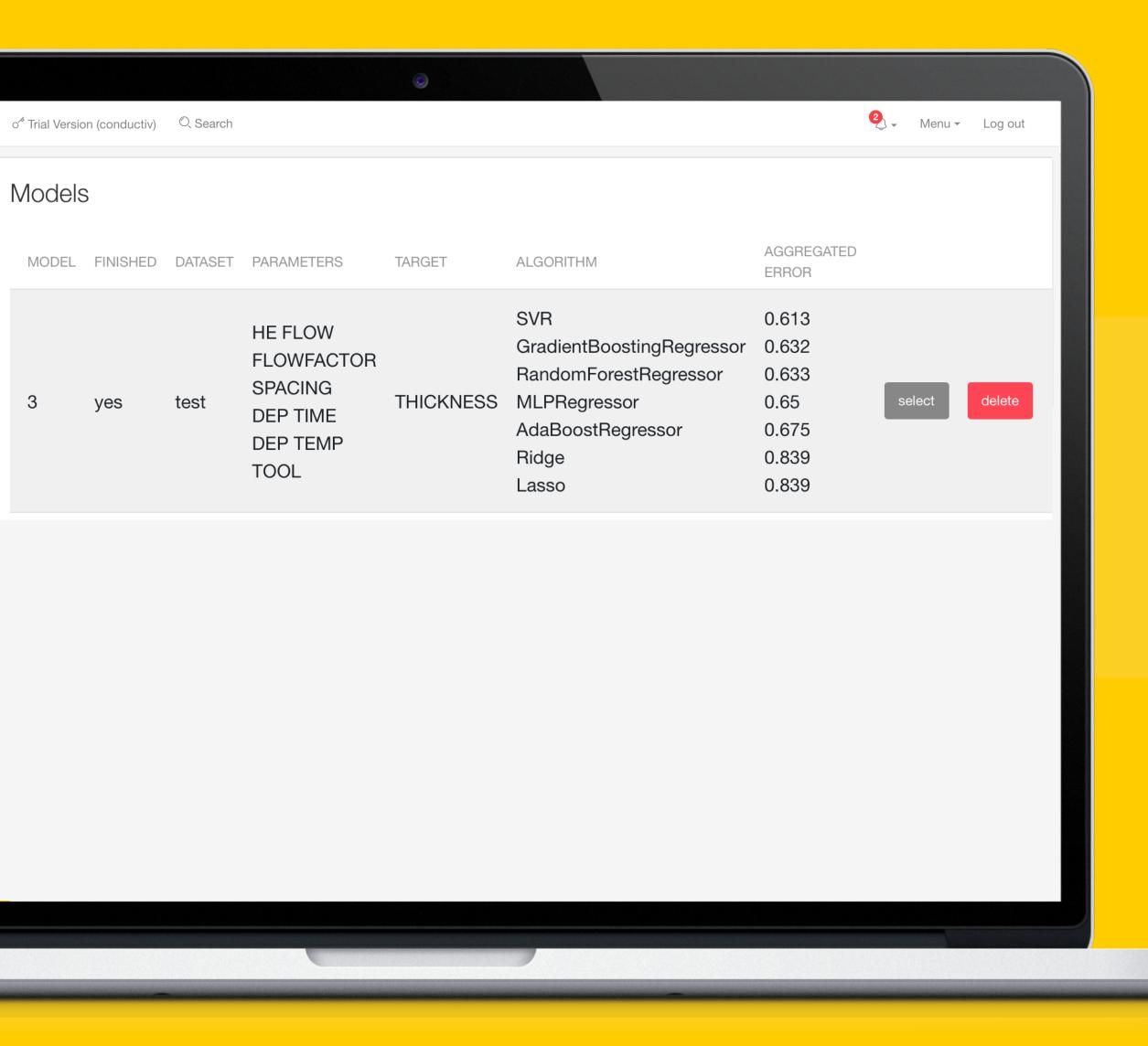
Missing Values & Imputation

Duplicates & Outliers

Normalization



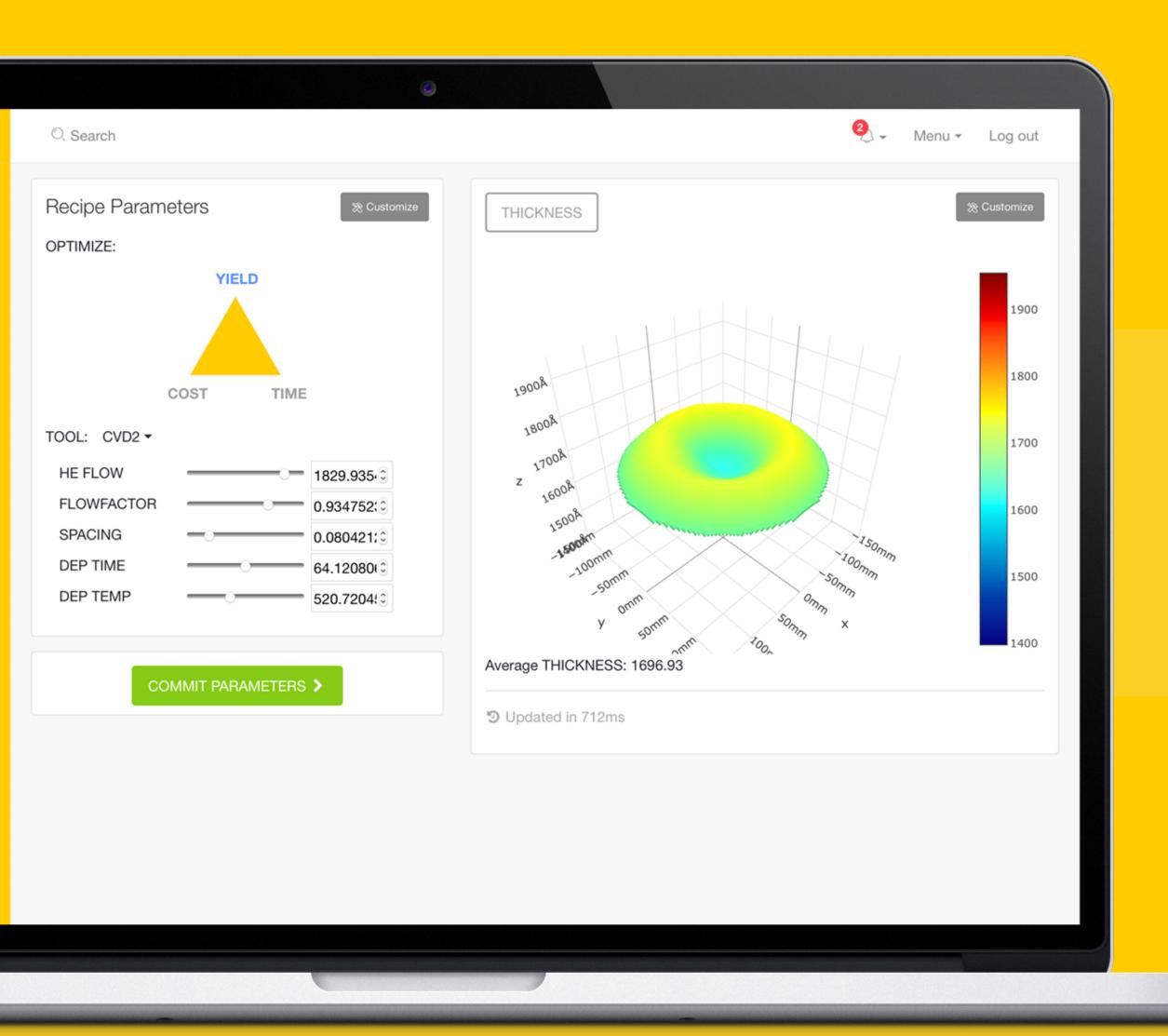
2. Automated Machine Learning



Feature Engineering
Algorithm Selection
Parameter Optimization



3. Recipe Optimization



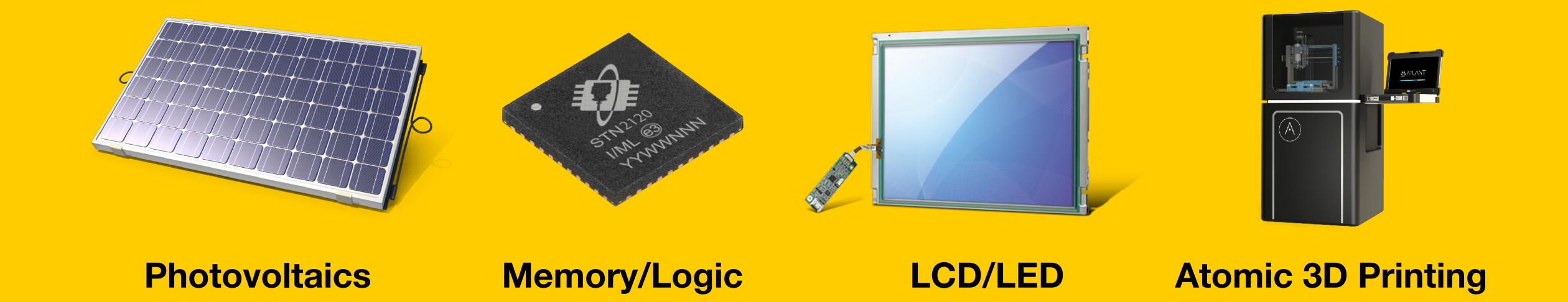
User-Specified Criteria

Localized Recipes

Real-Time Visualization



Manufacturing Process Control

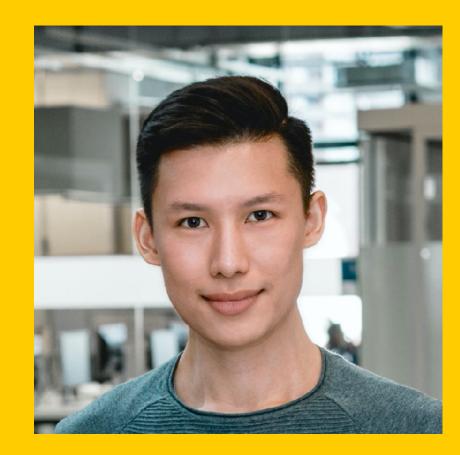


\$8B TAM



Complementary Team

Calvin Ng



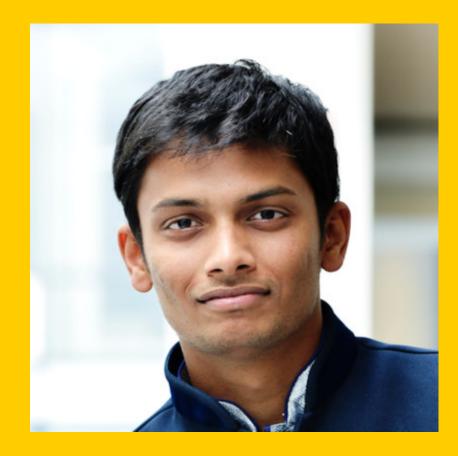
APPLIED MATERIALS

Vadim Pinskiy



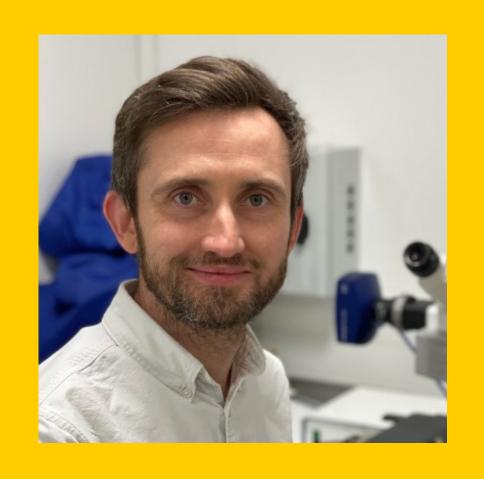
nanotronics

Vamsi Spandan



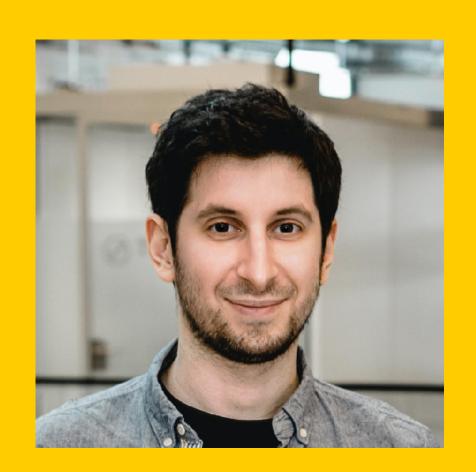


Patrick Parkinson





Mark Ayzenshtadt







Zero-Iteration Manufacturing